Vincotech

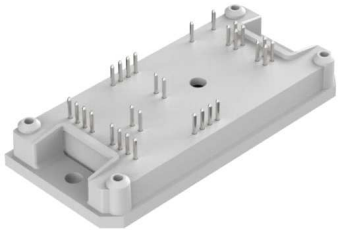
10-FY07NBA075S5-M505L58
datasheet

***flow* BOOST 1 symmetric** **650 V / 75 A**

Features

- High efficient and compact symmetric booster
- High switching frequency and low inductive design
- Low losses with TRENCHSTOP™ S5 IGBT
- Integrated temperature sensor

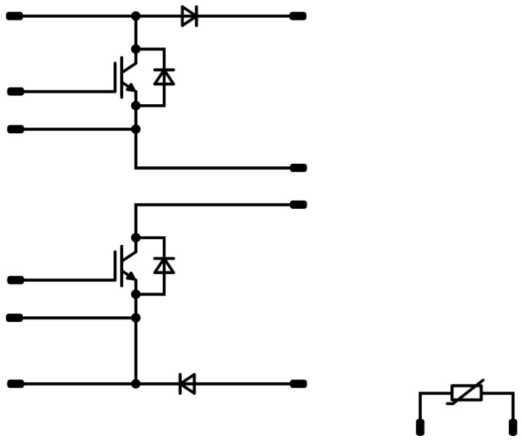
flow 1 12 mm housing



Target applications

- Solar
- UPS
- Power Supply

Schematic



Types

- 10-FY07NBA075S5-M505L58

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Boost Switch				
Collector-emitter voltage	V_{CES}		650	V
Collector current	I_C	$T_j = T_{jmax}$ T_s = 80 °C	58	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	225	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ T_s = 80 °C	86	W
Gate-emitter voltage	V_{GES}		±20	V
Maximum junction temperature	T_{jmax}		175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Boost Diode				
Peak Repetitive Reverse Voltage	V_{RRM}		650	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$ T_s = 80 °C	59	A
Repetitive peak forward current	I_{FRM}		150	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ T_s = 80 °C	78	W
Maximum Junction Temperature	T_{jmax}		175	°C
Boost Sw. Protection Diode				
Peak Repetitive Reverse Voltage	V_{RRM}		650	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$ T_s = 80 °C	21	A
Repetitive peak forward current	I_{FRM}		30	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ T_s = 80 °C	40	W
Maximum Junction Temperature	T_{jmax}		175	°C
Module Properties				
Thermal Properties				
Storage temperature	T_{stg}		-40…+125	°C
Operation temperature under switching condition	T_{jop}		-40…(T_{jmax} - 25)	°C
Isolation Properties				
Isolation voltage	V_{isol}	DC Test Voltage* t_p = 2 s	6000	V
		AC Voltage t_p = 1 min	2500	V
Creepage distance			min. 12,7	mm
Clearance			8,44	mm
Comparative Tracking Index	CTI		> 200	

*100 % tested in production

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Boost Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE} = V_{CE}$			0,00075	25	3,2	4	4,8	V
Collector-emitter saturation voltage	V_{CEsat}		15		75	25 125 150		1,56 1,56 1,59	1,75	V
Collector-emitter cut-off current	I_{CES}		0	650		25			50	µA
Gate-emitter leakage current	I_{GES}		20	0		25			100	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f= 1 Mhz	0	25		25		4500		pF
Output capacitance	C_{oes}							130		
Reverse transfer capacitance	C_{res}							17		
Gate charge	Q_g		15	520	75	25		164		nC
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material λ = 3,4 W/mK						1,10		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{goff} = 4 Ω R_{gon} = 4 Ω	15/0	350	75	25 125 150		24 24 24		ns
Rise time	t_r					25 125 150		11 12 12		
Turn-off delay time	$t_{d(off)}$					25 125 150		127 145 150		
Fall time	t_f					25 125 150		22 30 36		
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 2,5 µC Q_{rFWD} = 4,7 µC Q_{rFWD} = 5,4 µC				25 125 150		0,379 0,605 0,681		mWs
Turn-off energy (per pulse)	E_{off}					25 125 150		0,854 1,240 1,360		

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Boost Diode										
Static										
Forward voltage	V_F				75	25 125 150		1,53 1,49 1,47	1,92	V
Reverse leakage current	I_r			650		25			3,8	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material λ = 3,4 W/mK						1,23		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt = 8536 A/µs di/dt = 6881 A/µs di/dt = 6458 A/µs	15/0	350	75	25 125 150		92 116 123		A
Reverse recovery time	t_{rr}					25 125 150		53 84 94		ns
Recovered charge	Q_r					25 125 150		2,488 4,663 5,377		µC
Reverse recovered energy	E_{rec}					25 125 150		0,672 1,267 1,457		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125 150		2911 2634 2713		A/µs
Boost Sw. Protection Diode										
Static										
Forward voltage	V_F				15	25 125		1,79 1,67	1,87	V
Reverse leakage current	I_r			650		25			0,18	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material λ = 3,4 W/mK						2,36		K/W

Characteristic Values

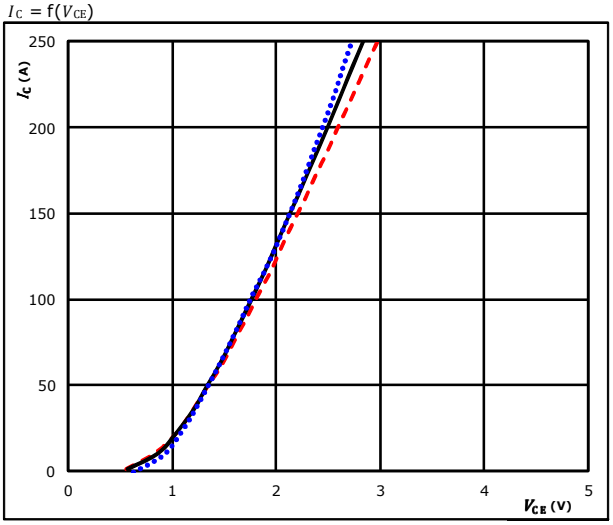
Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Thermistor										
Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$\Delta_{R/R}$	R_{100} = 1484 Ω				100	-5		5	%
Power dissipation	P					25		5		mW
Power dissipation constant						25		1,5		mW/K
B-value	$B_{(25/50)}$	Tol. ±1 %				25		3962		K
B-value	$B_{(25/100)}$	Tol. ±1 %				25		4000		K
Vincotech NTC Reference									I	

Boost Switch Characteristics

figure 1. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

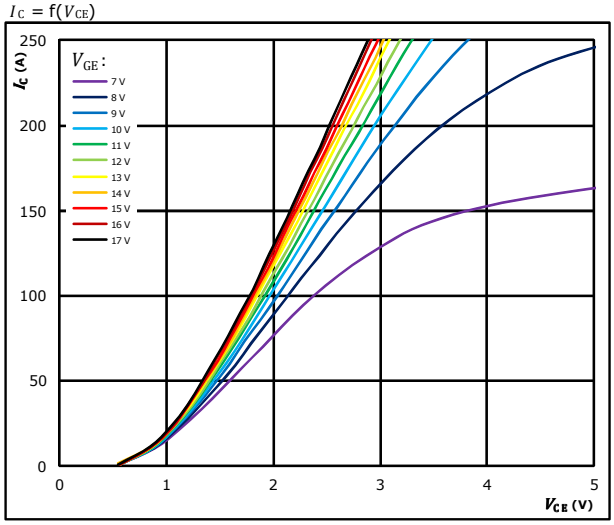


t_p =	250	µs		25 °C	
V_{GE} =	15	V	T_j:	125 °C	
				150 °C	

figure 2. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

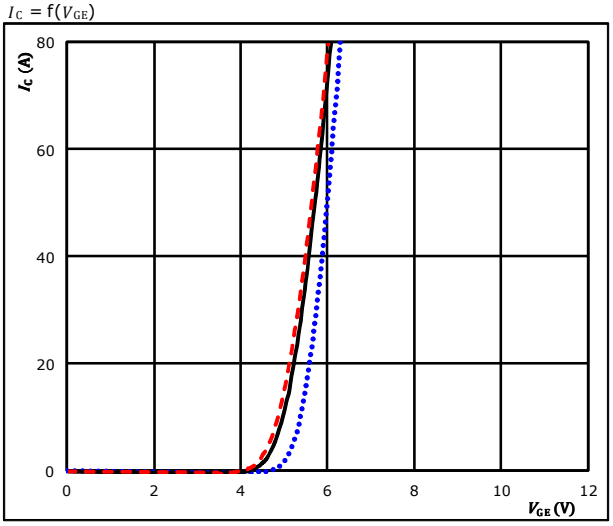


t_p =	250	µs
T_j =	150	°C
V_{GE} from	7 V to 17 V in steps of 1 V	

figure 3. **IGBT**

Typical transfer characteristics

$I_C = f(V_{GE})$

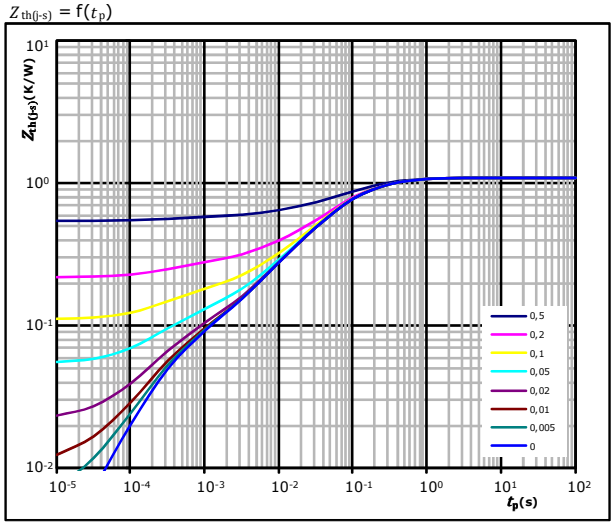


t_p =	100	µs		25 °C	
V_{CE} =	10	V	T_j:	125 °C	
				150 °C	

figure 4. **IGBT**

Transient thermal impedance as function of pulse duration

$Z_{th(j-s)} = f(t_p)$



D =	t_p / T	
$R_{th(j-s)}$ =	1,10	K/W

IGBT thermal model values

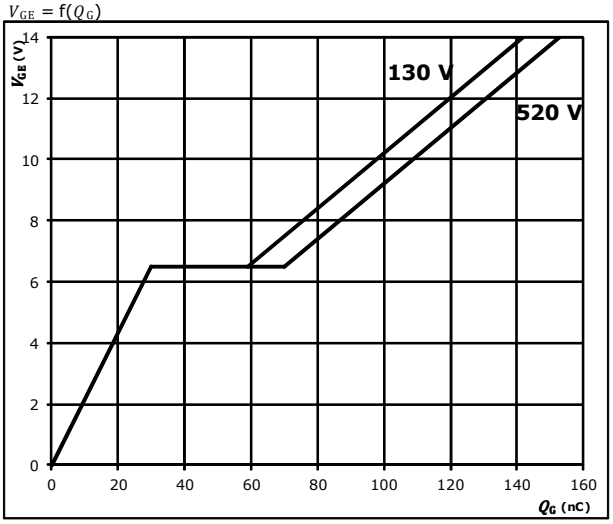
R (K/W)	τ (s)
2,16E-01	4,05E-01
6,30E-01	6,87E-02
1,62E-01	1,13E-02
3,68E-02	2,51E-03
6,02E-02	3,09E-04

Boost Switch Characteristics

figure 5. **IGBT**

Gate voltage vs gate charge

$V_{GE} = f(Q_G)$

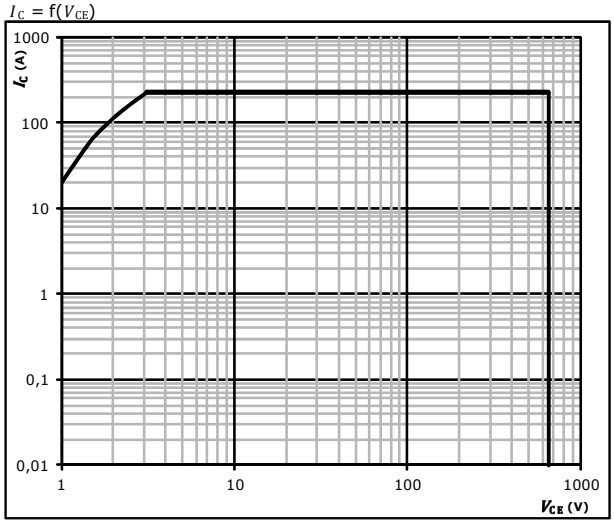


I_C= 75 A

figure 6. **IGBT**

Safe operating area

$I_C = f(V_{CE})$



D = single pulse

T_s = 80 °C

V_{GE} = ±15 V

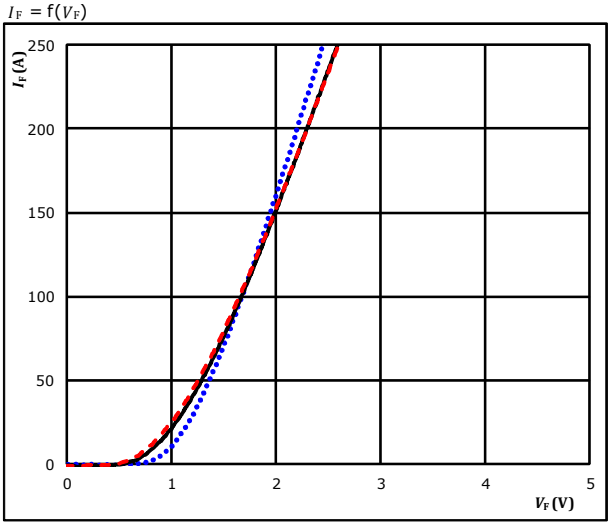
T_j = T_{jmax}

Boost Diode Characteristics

figure 1. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



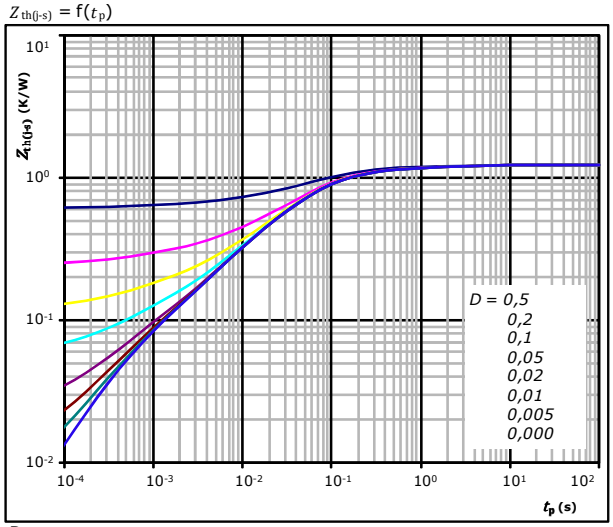
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 2. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



D = t_p / T

$R_{th(j-s)}$ = 1,23 K/W

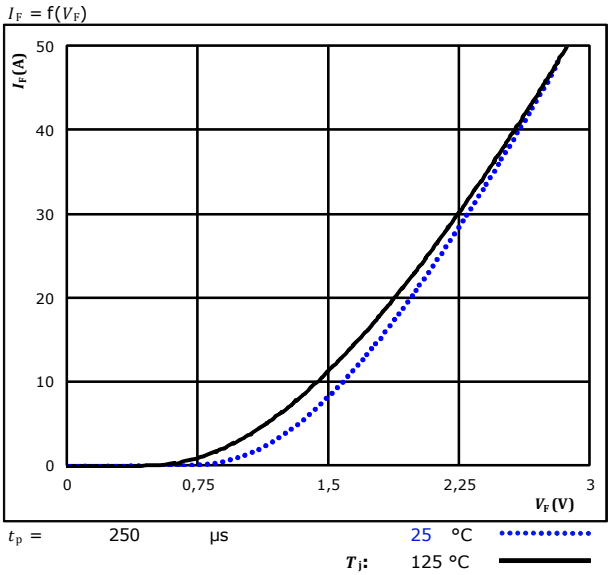
FWD thermal model values

R (K/W)	τ (s)
8,04E-02	2,68E+00
1,74E-01	2,85E-01
6,28E-01	6,23E-02
2,05E-01	1,65E-02
8,90E-02	4,15E-03
4,76E-02	4,96E-04

Boost Sw. Protection Diode Characteristics

figure 1. **FWD**

Typical forward characteristics



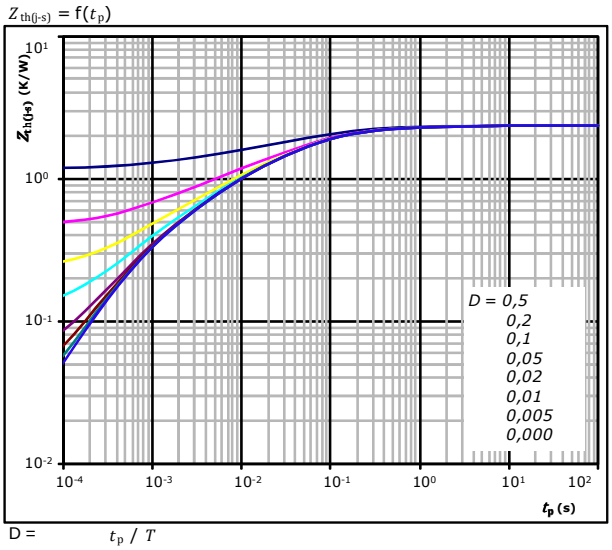
t_p = 250 µs

T_j: 25 °C

T_j: 125 °C

figure 2. **FWD**

Transient thermal impedance as a function of pulse width



D = t_p / T

$R_{th(j-s)}$ = 2,36 K/W

FWD thermal model values

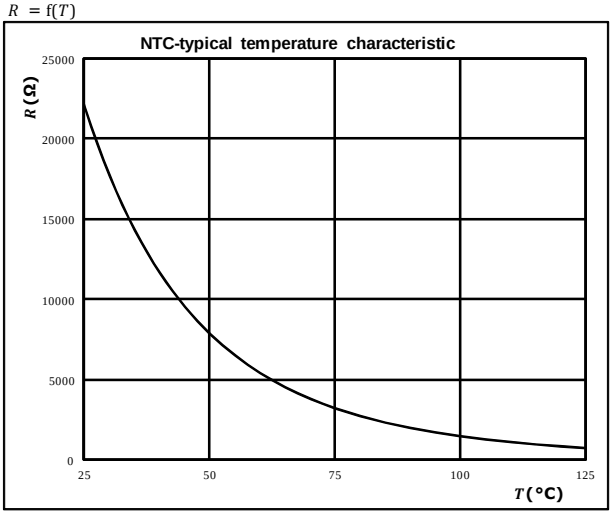
R (K/W)	τ (s)
9,10E-02	3,90E+00
2,66E-01	3,08E-01
8,25E-01	6,57E-02
5,40E-01	1,54E-02
4,23E-01	3,41E-03
2,13E-01	5,87E-04

Thermistor Characteristics

figure 1. **Thermistor**

Typical NTC characteristic as a function of temperature

$R = f(T)$

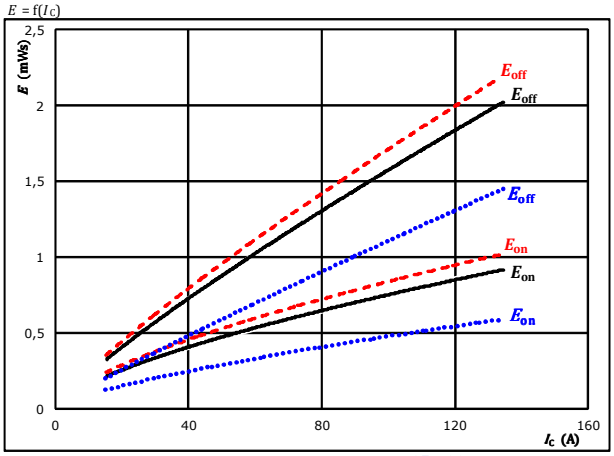


Switching Characteristics

figure 1. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



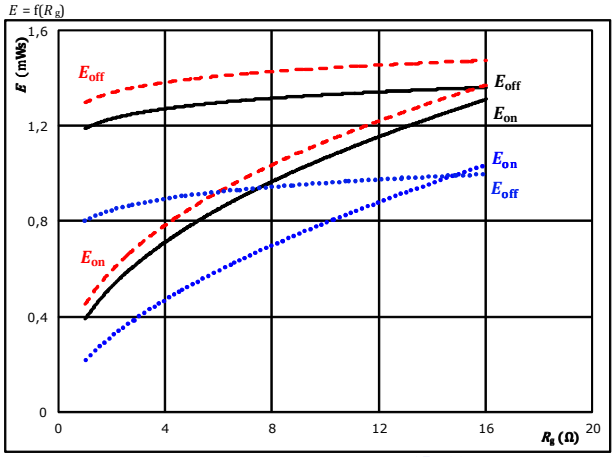
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C	
V_{GE} =	15/0	V		125 °C	
R_{gon} =	4	Ω		150 °C	
R_{goff} =	4	Ω			

figure 2. **IGBT**

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



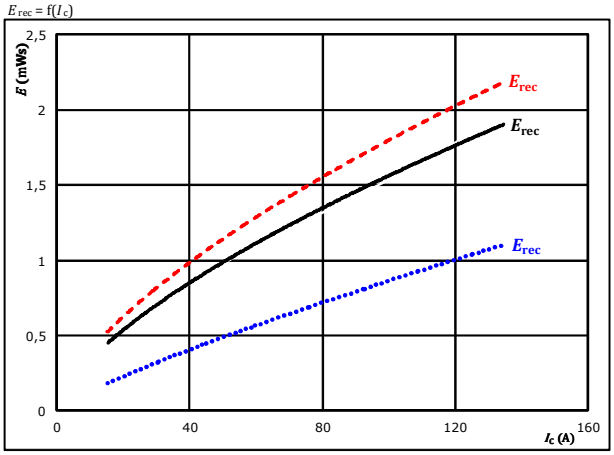
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C	
V_{GE} =	15/0	V		125 °C	
I_C =	75	A		150 °C	

figure 3. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



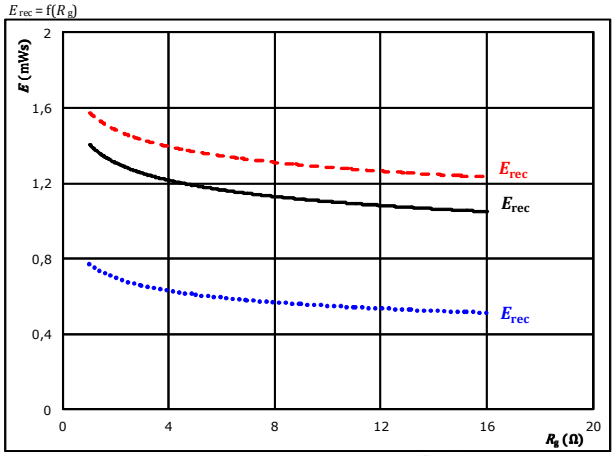
With an inductive load at

V_{CE} =	350	V	T_J:	25 °C	
V_{GE} =	15/0	V		125 °C	
R_{gon} =	4	Ω		150 °C	

figure 4. **FWD**

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

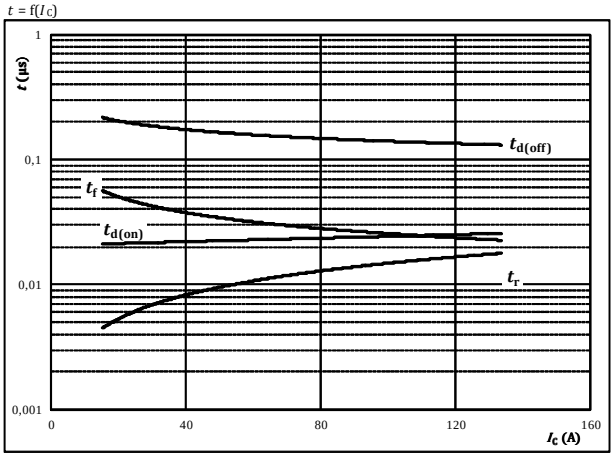
V_{CE} =	350	V	T_J:	25 °C	
V_{GE} =	15/0	V		125 °C	
I_C =	75	A		150 °C	

Switching Characteristics

figure 5. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



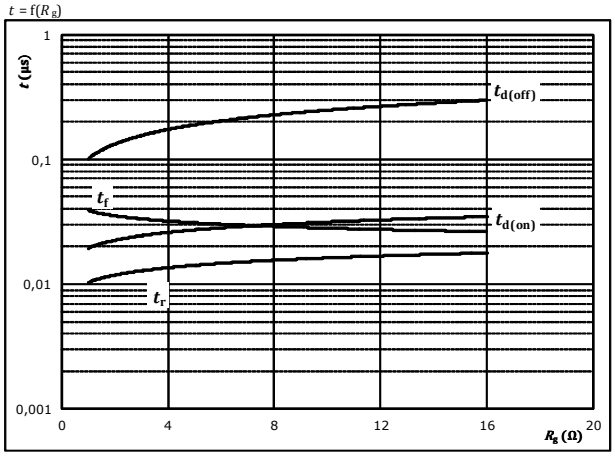
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	15/0	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

figure 6. **IGBT**

Typical switching times as a function of gate resistor

$t = f(R_g)$



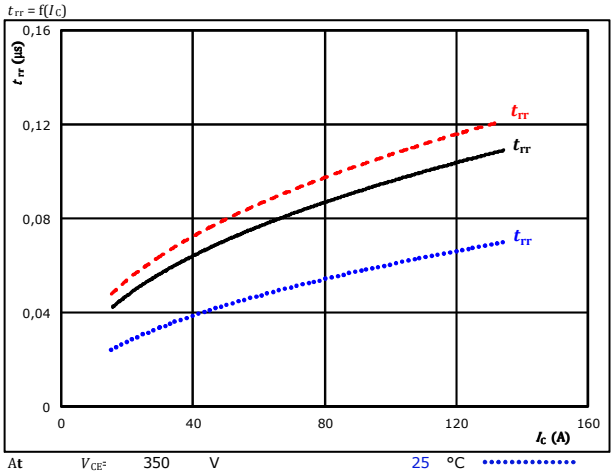
With an inductive load at

T_j =	150	°C
V_{CE} =	350	V
V_{GE} =	15/0	V
I_C =	75	A

figure 7. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



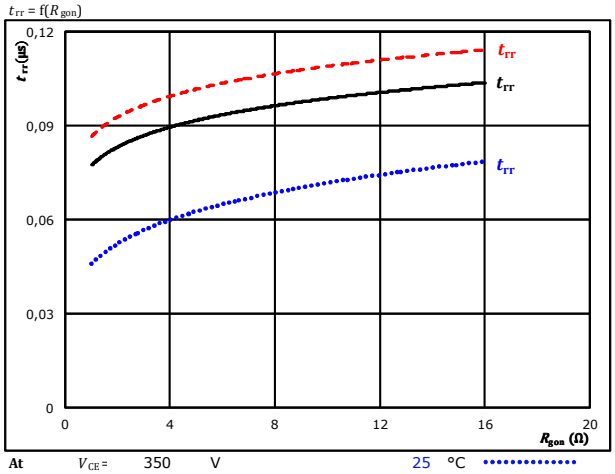
At

V_{CE} =	350	V	T_j:	25 °C	·····
V_{GE} =	15/0	V		125 °C	———
R_{gon} =	4	Ω		150 °C	– – –

figure 8. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



At

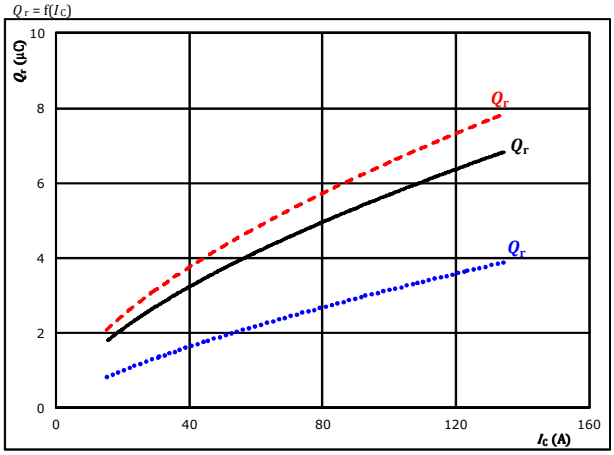
V_{CE} =	350	V	T_j:	25 °C	·····
V_{GE} =	15/0	V		125 °C	———
I_C =	75	A		150 °C	– – –

Switching Characteristics

figure 9. FWD

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$

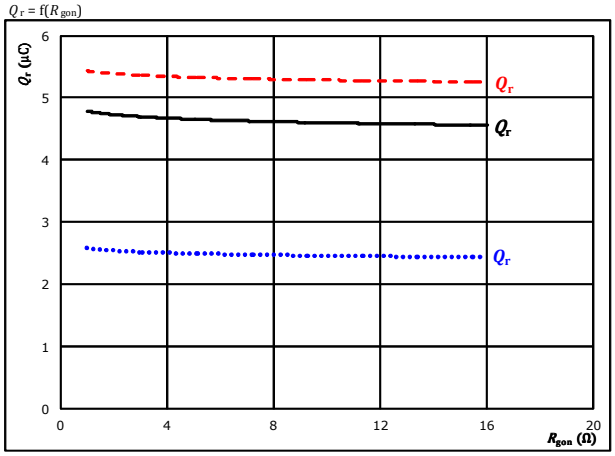


At						
	V_{CE} =	350	V		25 °C	
	V_{GE} =	15/0	V	T_j:	125 °C	
	R_{gon} =	4	Ω		150 °C	

figure 10. FWD

Typical recoved charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$

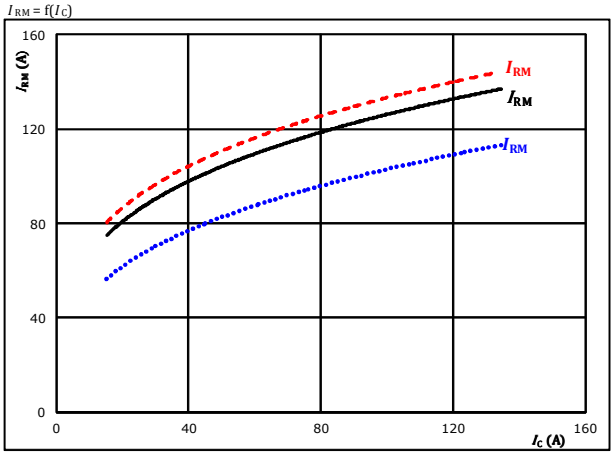


At						
	V_{CE}=	350	V		25 °C	
	V_{GE} =	15/0	V	T_j:	125 °C	
	I_C=	75	A		150 °C	

figure 11. FWD

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$

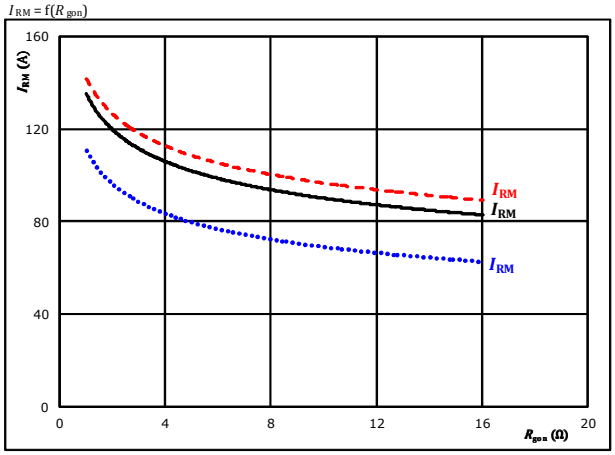


At						
	V_{CE}:	350	V		25 °C	
	V_{GE} =	15/0	V	T_j:	125 °C	
	R_{gon} =	4	Ω		150 °C	

figure 12. FWD

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



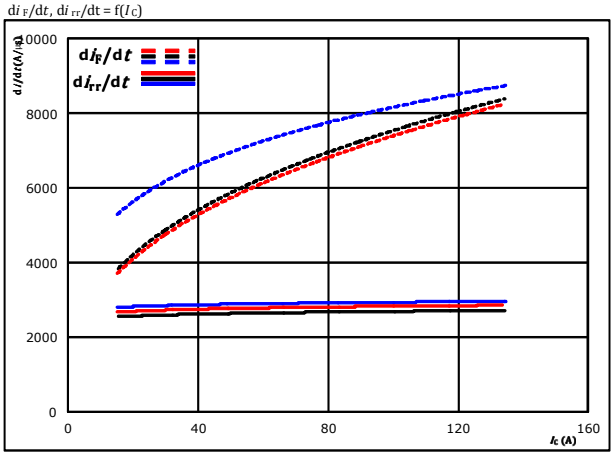
At						
	V_{CE} =	350	V		25 °C	
	V_{GE} =	15/0	V	T_j:	125 °C	
	I_C =	75	A		150 °C	

Switching Characteristics

figure 13. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, $di_{rr}/dt = f(I_C)$

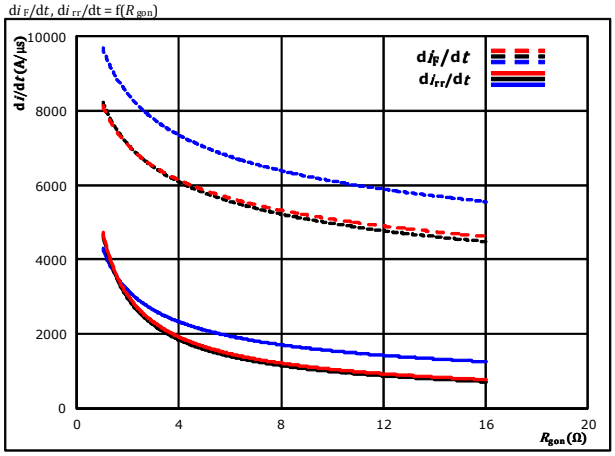


At						
V_{CE}=	350	V		25 °C	●●●●●●●●●●●●●●
V_{GE}=	15/0	V	T_j:	125 °C	———
R_{gon}=	4	Ω		150 °C	- - - -

figure 14. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

di_F/dt, $di_{rr}/dt = f(R_{gon})$

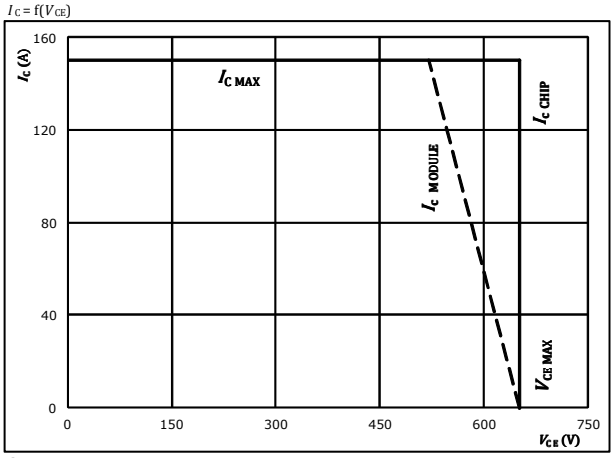


At						
V_{CE}=	350	V		25 °C	●●●●●●●●●●●●●●
V_{GE}=	15/0	V	T_j:	125 °C	———
I_C=	75	A		150 °C	- - - -

figure 15. **IGBT**

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

T_j =	175	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

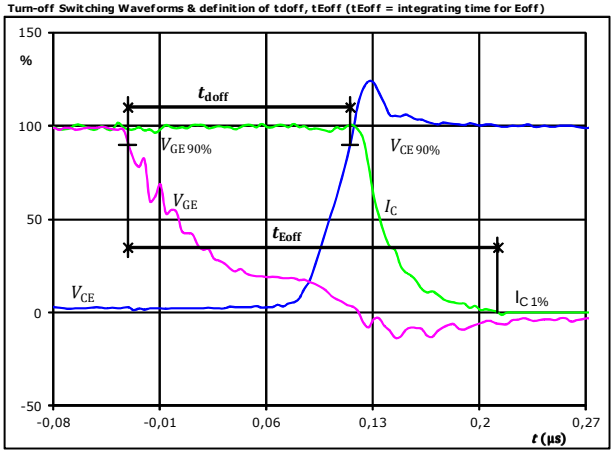
Switching Definitions

General conditions

T_j	=	**125 °C**
R_{gon}	=	**4 Ω**
R_{goff}	=	**4 Ω**

figure 1. IGBT

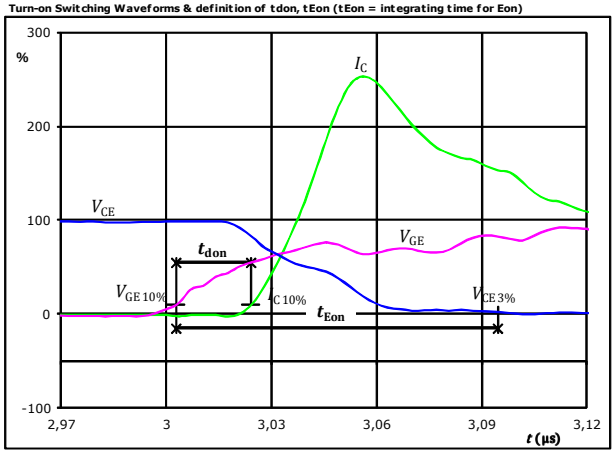
Turn-off Switching Waveforms & definition of tdoff, tEoff (tEoff = integrating time for Eoff)



$V_{GE}(0\%)$ =	0	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_{doff} =	0,145	µs
t_{Eoff} =	0,243	µs

figure 2. IGBT

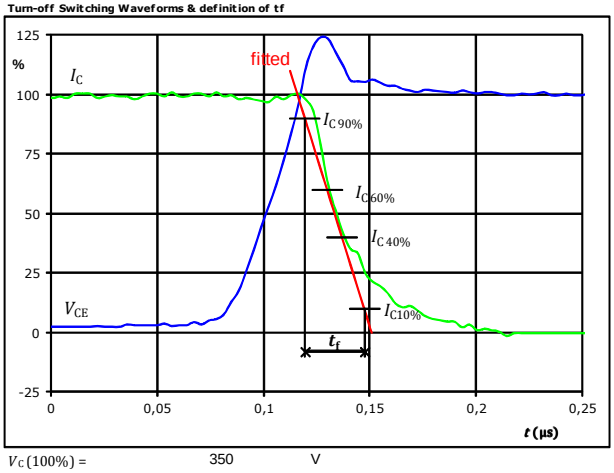
Turn-on Switching Waveforms & definition of tdon, tEon (tEon = integrating time for Eon)



$V_{GE}(0\%)$ =	0	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_{don} =	0,024	µs
t_{Eon} =	0,092	µs

figure 3. IGBT

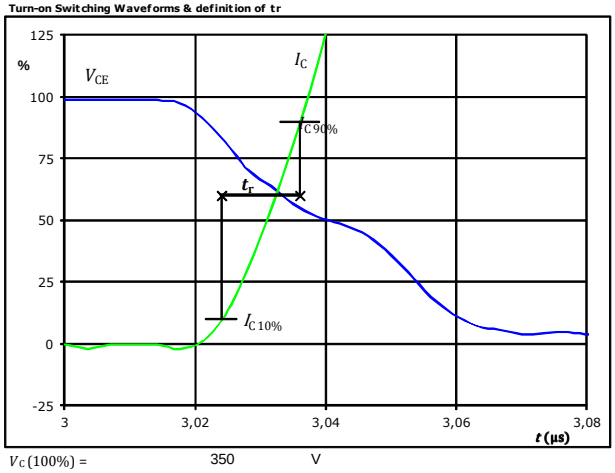
Turn-off Switching Waveforms & definition of tf



$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_f =	0,030	µs

figure 4. IGBT

Turn-on Switching Waveforms & definition of tr

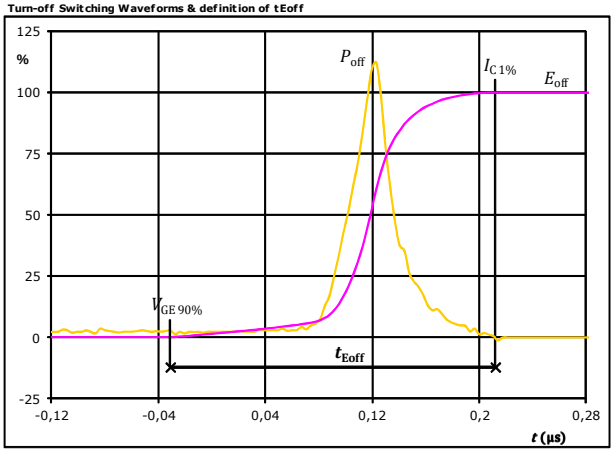


$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	75	A
t_r =	0,012	µs

Switching Characteristics

figure 5. **IGBT**

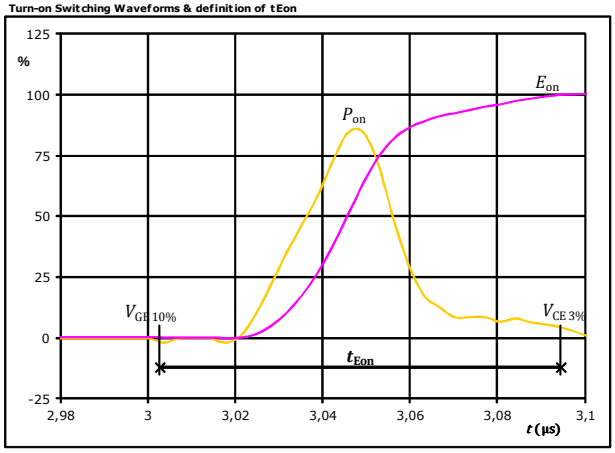
Turn-off Switching Waveforms & definition of tEoff



$P_{off}(100\%) =$	26,41	kW
$E_{off}(100\%) =$	1,24	mJ
$t_{Eoff} =$	0,24	µs

figure 6. **IGBT**

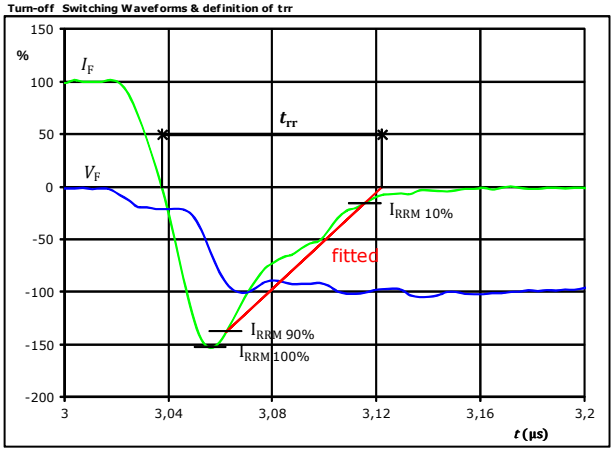
Turn-on Switching Waveforms & definition of tEon



$P_{on}(100\%) =$	26,41	kW
$E_{on}(100\%) =$	0,61	mJ
$t_{Eon} =$	0,09	µs

figure 7. **FWD**

Turn-off Switching Waveforms & definition of trr

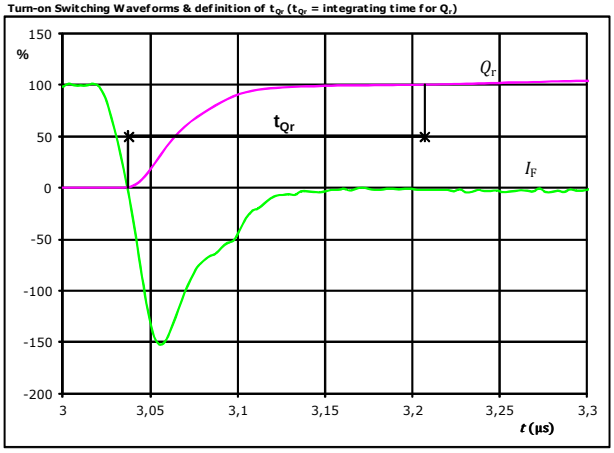


$V_F(100\%) =$	350	V
$I_F(100\%) =$	75	A
$I_{RRM}(100\%) =$	-116	A
$t_{rr} =$	0,084	µs

Switching Characteristics

figure 8. **FWD**

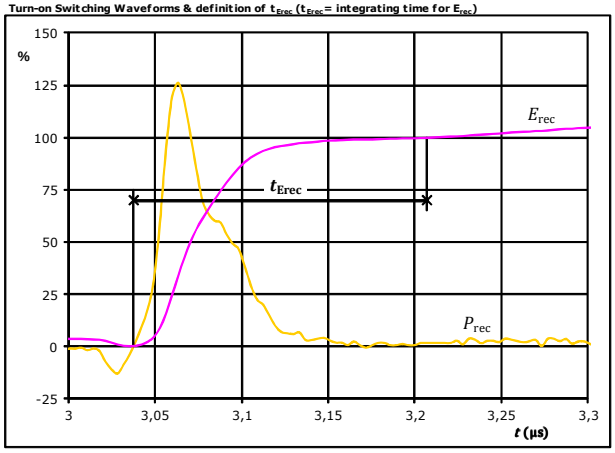
Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



I_F (100%) =	75	A
Q_r (100%) =	4,66	µC
t_{Qr} =	0,17	µs

figure 9. **FWD**

Turn-on Switching Waveforms & definition of t_{Erec} (t_{Erec} = integrating time for E_{rec})



P_{rec} (100%) =	26,41	kW
E_{rec} (100%) =	1,27	mJ
t_{Erec} =	0,17	µs

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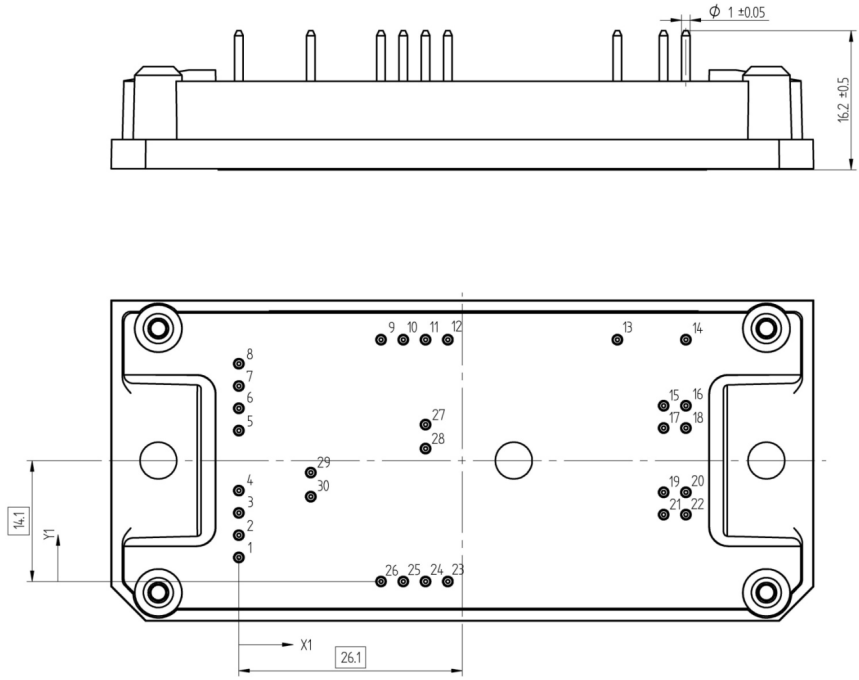
Ordering Code & Marking

Version	Ordering Code
without thermal paste 12 mm housing with solder pins	10-FY07NBA075S5-M505L58
with thermal paste 12 mm housing with solder pins	10-FY07NBA075S5-M505L58-/3/

		Name		Date code	UL & VIN	Lot	Serial
Text		NN-NNNNNNNNNNNNN-TTTTTTVV		WWYY	UL VIN	LLLLL	SSSS
		Type&Ver	**Lot number**	**Serial**	**Date code**		
Datamatrix		TTTTTTTVV	LLLLL	SSSS	WWYY		

Outline

Pin table			
Pin	X	Y	Function
1	0	2,8	GND+
2	0	5,4	GND+
3	0	8	GND+
4	0	10,6	GND+
5	0	17,6	GND-
6	0	20,2	GND-
7	0	22,8	GND-
8	0	25,4	GND-
9	16,6	28,2	DC-
10	19,2	28,2	DC-
11	21,8	28,2	DC-
12	24,4	28,2	DC-
13	44,2	28,2	NTC1
14	52,2	28,2	NTC2
15	49,6	20,5	B-
16	52,2	20,5	B-
17	49,6	17,9	B-
18	52,2	17,9	B-
19	49,6	10,4	B+
20	52,2	10,4	B+
21	49,6	7,8	B+
22	52,2	7,8	B+
23	24,4	0	DC+
24	21,8	0	DC+
25	19,2	0	DC+
26	16,6	0	DC+
27	21,8	18,3	E2
28	21,8	15,5	G2
29	8,4	12,7	G1
30	8,4	9,9	E1



Tolerance of pinpositions: ±0,5mm at the end of pins
Dimension of coordinate axis is only offset without tolerance

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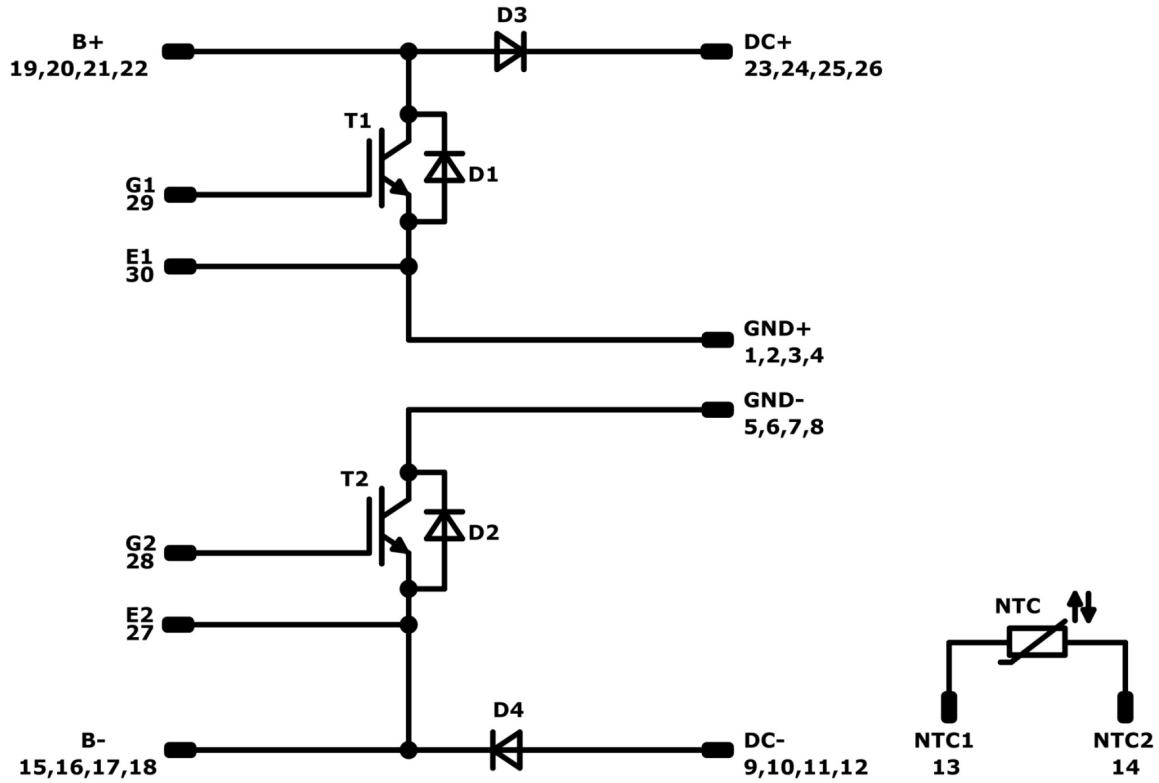
Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T2 , T1	IGBT	650 V	75 A	Boost Switch	
D4 , D3	FWD	650 V	75 A	Boost Diode	
D2 , D1	FWD	650 V	15 A	Boost Sw. Protection Diode	
NTC	NTC			Thermistor	

Packaging instruction				
Standard packaging quantity (SPQ) 100	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for *flow* 1 packages see vincotech.com website.

Package data
Package data for *flow* 1 packages see vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website.

Document No.:	Date:	Modification:	Pages
10-FY07NBA075S5-M505L58-D1-14	09 Jul. 2017		